

SHEET 1 OF 1

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

219453US90

SERIAL NO.

10/073,317

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Hitoshi YOSHINO, et al.

FILING DATE

February 13, 2002

GROUP

2666

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
RA	AO	4-500589	01/30/1992	JAPAN (with corr. WO 90/03071)		X
RA	AP	WO 90/03071	03/22/1990	WIPO		
RA	AQ	2000-59287	02/25/2000	JAPAN (with English Abstract, corr. EP 0 963 129 was filed on 08/26/02)		X
RA	AR	10-155181	06/09/1998	JAPAN (with English Abstract, corr. EP 0 841 826 was filed on 08/26/02)		X
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

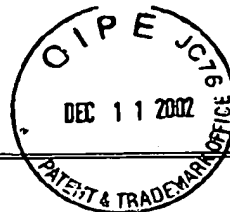
☐ Additional References sheet(s) attached

Examiner

*Ken Chelton*

Date Considered 11/17/05

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
219453US2SERIAL NO.  
10/073,317

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Hitoshi YOSHINO, et al.FILING DATE  
February 13, 2002GROUP  
2681

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>RA</i>	AA	5,095,535	03/10/92	T. A. FREEBURG			
<i>RA</i>	AB	4,513,412	04/23/85	D. C. COX			
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>RA</i>	AO	WO 99/14871	03/25/99	WIPO		
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

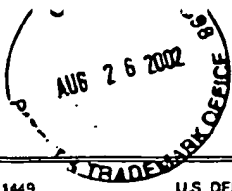
Examiner

*Ron Abelson*

Date Considered

*11/17/03*

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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	0 841 826	05/13/98	EUROPE		
	AP	0 963 129	12/08/99	EUROPE		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
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☐ Additional References sheet(s) attached

Examiner

Date Considered

11/17/03

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Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 219453US2		SERIAL NO. 10/073,317	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Hitoshi YOSHINO, et al.			
				FILING DATE February 13, 2002		GROUP 2681	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE		
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>RA</i> ↓	AO	10-248086	09/14/98	JAPAN (with English Abstract)		X	
	AP	11-346390	12/14/99	JAPAN (with English Abstract)		X	
	AQ	2000-59291	02/25/2000	JAPAN (with English Abstract)		X	
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Examiner <i>Ron Chelton</i>				Date Considered <i>11/17/05</i>			

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